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| 9 | 8 | Bhattacharyya and 704/.ccls. | USPAT: EPO: JPO | 2003/01/09 09:28 |
| 10 | 2 | ( Bhattacharyya and 704/.ccls.) and minim$8 | USPAT: EPO: JPO | 2003/01/09 09:29 |
| - | 5 | heteroscedastic | USPAT: EPO: JPO | 2003/01/06 12:30 |
| - | 5 | hessian and 704/.ccls. | USPAT: EPO: JPO | 2003/01/06 12:45 |

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|---|---|---|---|---|
| 1 | 49 | ("6058205" "5970239" "5754681" "6327581" "5768422" "5796863" "5805731" "5805730" "5903884" "6219642" "6219642" "6418412" "5854855" "5649068" "5839103" "5828998" "6134525" "6006182" "5806029" "5751904" "6480621" "5715367" "4918731" "5991442" "5960397" "5299284" "6128410" "5809465" "6195638" "5325445" "5255342" "6466926" "5703960" "6003003" "6044343" "6067515" "6070136" "6347297" "6272479" "5946410" "5757960" "5796924" "4323880" "5790754" "6021387" "6038338" "5835890" "5263097" "5920839" "6044344").pn. | USPAT: EPO: JPO | 2003/01/09 08:21 |
| 4 | 1 | pattern same transform$6 and feature same class$10 and minim$6 same probab$6 same misclass$10 and object$4 with function$4 and optimi$4 same gradient with descent | USPAT: EPO: JPO | 2003/01/09 09:01 |
| 6 | 2 | (("6058205" "5970239" "5754681" "6327581" "5768422" "5796863" "5805731" "5805730" "5903884" "6219642" "6219642" "6418412" "5854855" "5649068" "5839103" "5828998" "6134525" "6006182" "5806029" "5751904" "6480621" "5715367" "4918731" "5991442" "5960397" "5299284" "6128410" "5809465" "6195638" "5325445" "5255342" "6466926" "5703960" "6003003" "6044343" "6067515" "6070136" "6347297" "6272479" "5946410" "5757960" "5796924" "4323880" "5790754" "6021387" "6038338" "5835890" "5263097" "5920839" "6044344").pn. | USPAT: EPO: JPO | 2003/01/09 09:06 |
| 7 | 3 | ) and (max$4 and over$6 and pair$4 and diver$6) (("6058205" "5970239" "5754681" "6327581" "5768422" "5796863" "5805731" "5805730" "5903884" "6219642" "6219642" "6418412" "5854855" "5649068" "5839103" "5828998" "6134525" "6006182" "5806029" "5751904" "6480621" "5715367" "4918731" "5991442" "5960397" "5299284" "6128410" "5809465" "6195638" "5325445" "5255342" "6466926" "5703960" "6003003" "6044343" "6067515" "6070136" "6347297" "6272479" "5946410" "5757960" "5796924" "4323880" "5790754" "6021387" "6038338" "5835890" "5263097" "5920839" "6044344").pn. ) and (over$6 and pair$4 and diver$6) | USPAT: EPO: JPO | 2003/01/09 09:05 |

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